Charge carrier scattering and electronic transport in graphene

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Outline

1. Minimal conductivity
2. Scattering by point defects: Boltzmann equation
3. Scattering by point defects: bilayer
4. Charge impurities and cluster formation
5. Resonant scatterers
6. Scattering by flexural phonons (ripples): main mechanism for suspended samples?
Massless Dirac fermions

neglecting intervalley scattering:

massless Dirac fermions

sp² hybridization, π bands crossing the neutrality point

Symmetry protected (T and I)

FIG. 2: (color online) Band structure of a single graphene layer. Solid red lines are σ bands and dotted blue lines are π bands.
Minimal conductivity of the order of $e^2/h$ per channel.

Conductivity is approx. proportional to charge-carrier concentration $n$ (concentration-independent mobility).

Novoselov et al, Nature 2005
Quantum-Limited Resistivity

$E=0$

zero-gap semiconductor

Novoselov et al, Nature 2005

$\rho_{\text{max}} = (\hbar/4e^2) \mu (\text{cm}^2/\text{Vs})$

no temperature dependence in the peak between 3 and 80K

15 devices

$\rho_{\text{max}} (\text{k}\Omega)$ vs $V_g (\text{V})$
Transport via evanescent waves

MIK, EPJ B 51, 157 (2006)

Conductance = $e^2/h \ Tr \ T$ per valley per spin

$T$ is the transmission probability matrix

The wave functions of massless Dirac fermions at zero energy:

$$\psi_{\pm}(x, y) = \begin{cases} 0, & \partial_x \pm i \partial_y \psi_{\pm}(x, y) = 0 \\ f(x \pm iy), & \forall f \end{cases}$$

Boundary conditions determine the functions $f$
Transport via evanescent waves II

$f(y + L_y) = f(y)$

Edge states near the top and bottom of the sample

New type of electron transport: via evanescent waves – different from both ballistic and diffusive
Transport via evanescent waves III

Leads from doped graphene

\[ T_n = |t(k_y)|^2 = \frac{\cos^2 \phi}{\cosh^2(k_y L_x) - \sin^2 \phi} \]

\[ \sin \phi = \frac{k_y}{k_F} \]

\[ TrT = \sum_{n=-\infty}^{\infty} \frac{1}{\cosh^2(k_y L_x)} \approx \frac{L_y}{\pi L_x} \]

Conductivity per channel:

\[ \frac{e^2}{(\pi \hbar)} \]

The problem of “missing pi(e)” – may be, no problem
In very clean samples, the minimum conductivity is close to the theoretical prediction.
Back to minimal conductivity

Sometimes: conductivity much lower than $e^2/h$


Graphene encapsulated in hBN. Strong sensitivity to screening by another graphene layer, temperature and magnetic field.
Another recent experiment

Insulating Behavior at the Neutrality Point in Single-Layer Graphene

F. Amet, J. R. Williams, K. Watanabe, T. Taniguchi, and D. Goldhaber-Gordon

Also, graphene on hBN

Power-law behavior with temperature

\[ g_{CNP} \propto T^\alpha \text{ with } \alpha \approx 0.48 \pm 0.05 \]
Many-body renormalization

F. Guinea & MIK, PRL 112, 116604 (2014)


Overlap of the wave functions are suppressed by overlap of the wave functions of environment (then, averaging over the environment)

Transport via evanescent waves is tunneling

Nonlocal self-interaction

e-h pairs as thermal bath
Many-body renormalization II

Correction to the effective tunneling action

\[ \delta S = \frac{1}{2} \int_{-\infty}^{+\infty} d\tau \int_{0}^{\beta} d\tau' \int_{-\infty}^{+\infty} \frac{dq}{2\pi} \int_{-\infty}^{+\infty} d\omega \, e^{iq[x(\tau) - x(\tau') - \omega|\tau - \tau'|]} W(q, \omega) \]

Screened Coulomb interaction

\[ W(q, \omega) = \frac{v_q}{\epsilon(q, \omega)} \]

Bare Coulomb interaction

\[ v_q \approx \begin{cases} -\frac{2e^2}{\epsilon_0} \log(qL_y) & qL_y \ll 1 \\ \frac{2\pi e^2}{\epsilon_0 qL_y} & 1 \ll qL_y \end{cases} \]

For undoped graphene

\[ \epsilon(q, \omega) = 1 + v_q \chi_{1D}(q, \omega) \]

\[ \chi_{1D}(q, \omega) \approx L_y \chi_{2D}(q, \omega) \approx L_y \frac{q^2}{4\sqrt{v_F^2 q^2 - \omega^2}} \]
Many-body renormalization III

Suppression of tunneling probability

\[ T(k_y) \approx T_0(k_y) e^{-\delta S} \]

\[ \delta S_G \approx \frac{L_x}{8\pi L_y} \frac{\alpha^2}{4\sqrt{2} + \alpha} \log \left( \frac{L_x}{a} \right) \]

for isolated graphene

In the presence of metallic layer:

\[ g = k_F \ell \]

\[ \chi_{1D}^M(q, \omega) \approx \begin{cases} \frac{u_{1D}D q^2}{i\omega + D q^2} & q \leq \ell^{-1} \\ \frac{u_{1D}v_F^M q}{i\omega + v_F^M q} & \ell^{-1} \leq q \leq k_F \end{cases} \]

\[ \delta S_M = \delta S_d + \delta S_b \approx \frac{L_x^2}{4\pi g \ell L_y} + \frac{L_x}{8\pi L_y} \log(g) \]
Many-body renormalization IV

At finite temperatures the cut-off wave vector

\[ q_c \approx \text{Max} \left( L_x^{-1}, \frac{T}{v_F} \right) \]

Magnetic field effects on diffusion!

**FIG. 2.** Temperature dependence of the inverse conductance, normalized to the non-interaction value, \( \sigma_0 = \frac{e^2}{\pi h} \), for \( L_x = 4 \mu \) and \( L_y = 1 \mu \). Red: Contribution from the graphene excitations, \( \delta S_G \), eq. 6. Blue: Contribution from a metallic layer, \( \delta S_M \), eq. 8. The two terms which describe the contribution from the metal, \( \delta S_d \) and \( \delta S_b \) are shown in the inset. Green: diffusive part, \( \delta S_d \) in eq. 8. Magenta: ballistic part, \( \delta S_b \) in eq. 8. The carrier density in the metal is \( n = 10^{11} \text{cm}^{-1} \), and the elastic mean free path is \( \ell = 100 \text{nm} \).
Scattering by point defects

\[ \sigma = \frac{e^2}{h} 2\varepsilon_F \tau, \quad \tau^{-1} = v_F n_{\text{imp}} \sigma_{\text{tr}} \]

\[ \sigma_{\text{tr}} = \int d\varphi (1 - \cos \varphi)|f(\varphi)|^2 = \frac{4}{k} \sum_{m=0}^{\infty} \sin^2 \theta_m \]

\[ f(\varphi) = \frac{2i}{\sqrt{2\pi}ik} \sum_{m=0}^{\infty} (e^{2i\delta_m} - 1) \cos \left( m + \frac{1}{2} \right) \varphi \]

\[ \theta_m = \delta_m - \delta_{m+1} \]

The back scattering ($\phi = \pi$) is absent rigorously (cf Klein tunneling)

s-scattering phase should be approx. constant at $k \to 0$; for a generic short-range potential it vanishes as $kR$ (cf. optics). Long-range (or resonant) scattering is required.

Justification of standard Boltzmann equation except very small doping: $n > \exp(-\pi\sigma h/e^2)$, or $\varepsilon_F \tau >> 1/|\ln(k_F a)|$ (M.Auslender and MIK, PRB 2007)
Low-energy description: \textbf{Massive} chiral fermions

\[
H = \begin{pmatrix}
0 & -(p_x - ip_y)^2/2m \\
-(p_x + ip_y)^2/2m & 0
\end{pmatrix}
\]

Constant DOS, no difference between charged and neutral impurities: short-range potential, anyway

\[
V(q) = \frac{2\pi Ze^2}{\epsilon(q + \kappa)}
\]

\[
\kappa = 2\pi e^2 N(E_F) / \epsilon
\]

Screening radius is about 4.5 Interatomic distances
Bilayer II

Radial wave equation:

\[
\left( \frac{d}{dr} - \frac{l + 1}{r} \right) \left( \frac{d}{dr} - \frac{l}{r} \right) g_l = \left( k^2 - \frac{2mV}{\hbar^2} \right) f_l, \\
\left( \frac{d}{dr} + \frac{l + 1}{r} \right) \left( \frac{d}{dr} + \frac{l + 2}{r} \right) f_l = \left( k^2 - \frac{2mV}{\hbar^2} \right) g_l,
\]

\[l = 0, \pm 1, \ldots,\]

\[g_l(r) e^{il\phi} \text{ and } f_l(r) e^{i(l+2)\phi}\]

are spinor components
Bilayer III

Beyond the range of potential – not only scattered wave but also evanescent waves:

\[ g_l(r) = A [J_l(kr) + t_l H^{(1)}_l(kr) + c_l K_l(kr)] , \]

\[ f_l(r) = A [J_{l+2}(kr) + t_l H^{(1)}_{l+2}(kr) + c_l K_{l+2}(kr)] , \]

Symmetry property: \( f \leftrightarrow g, \ l \leftrightarrow -l - 2 \)

\[ \frac{d\sigma(\phi)}{d\phi} = \frac{2}{\pi k} \left| t_{-1} + 2 \sum_{l=0}^{\infty} t_l \cos[(l + 1)\phi] \right|^2 \]
For small wave vectors:

\[ t_0(k) \text{ tends to a finite complex number} \]

\[
\frac{d\sigma(\phi)}{d\phi} = \frac{8}{\pi k} |t_0(k)|^2 \cos^2 \phi
\]

Resistivity estimation like for long-ranged potential in the single-layer graphene:

\[
\left(\frac{h}{4e^2}\right)n_{\text{imp}}/n
\]

No logarithmic corrections!
Explanation by default: charge impurities

Coulomb potential

\[ V_0 (r) = \frac{Ze^2}{\epsilon r} \]

Scattering phases are energy independent.
Scattering cross section \( \sigma \) is proportional to \( 1/k \)
(concentration independent mobility as in experiment)
(Nomura & MacDonald, PRL 2006; Ando, JPSJ 2006 – linear screening theory)

Nonlinear screening (MIK, PRB 2006); exact solution of Coulomb-Dirac problem (Shytov, MIK & Levitov PRL 2007; Pereira & Castro Neto PRL 2007; Novikov PRB 2007 and others). Relativistic collapse for supercritical charges!!!
**Experimental situation**

Ponomarenko et al, PRL 102, 206603 (2009)
Almost no sensitivity to screened medium (ethanol, $\kappa = 25$), glycerol, water and to dielectric constant of substrate

Couto et al, PRL 107, 225501 (2011)

Graphene on SrTiO$_3$:
Very large and strongly $T$-dependent $\kappa$ (from 200-300 @RT to 5000 at $T = 0$)
Almost no temperature dependence of transport
Explanation: clusterization of charge impurities??
MIK, Guinea and Geim, PR B 79, 195426 (2009)
For some charge impurities (e.g., Na, K…) barriers are low (< 0.1 eV) and there is tendency to clusterization

Exp. review: Caragiu & Finberg, JPCM 17, R995 (2005)

Simplest model: just circular cluster, constant potential (shift of chemical potential)

\[
g = \frac{e^2}{h} k_F l \sim \begin{cases} \frac{e^2}{h} \frac{1}{n_C R^2} & k_F R \ll 1 \\ \frac{e^2}{h} \frac{k_F^2 R^2}{n_C} & k_F R \gg 1 \end{cases}
\]

Correct concentration dependence, weakening of scattering in two order of magnitude due to clusterization!
Clusterization II

(Wehling, MIK & Lichtenstein, PR B 80, 085428 (2009)

Positions \( t \) (top of C atom) vs \( h \) (middle of hexagon):

Covalent (neutral impurities usually have high barriers,
Ionic (charged) impurities have lower barriers

Resonant impurities survive, charged impurities form clusters?

Still under discussions!
Gold cluster formation on graphene (AFM)

Mobility increases, Dirac point shifts

Experiment: Au clusterization on graphene
McCreary et al, PRB 81, 115453 (2010)
Resonant impurities

Experimentally: exfoliated graphene is polluted by organic stuff; mobility correlates with the forbidden Raman $D$ peak (Manchester group 2010)

Wehling, Yuan, Lichtenstein, Geim & MIK, PRL 105, 056802 (2010)

Pollution by organics, C-C bridges (one per 1000 to 10000 atoms is enough); hidden from STM!
Resonant impurities II

Effective hybridization model

\[ \hat{H} = \sum_{ij} t_{ij} \hat{c}_i^+ \hat{c}_j + \sum_{ij} \gamma_{ij} \left( \hat{c}_i^+ \hat{d}_j + \hat{d}_j^+ \hat{c}_i \right) + E_d \sum_i \hat{d}_i^+ \hat{d}_i \]

\[ \gamma_{ij} = \gamma \delta_{ij} \]

Effective on-site potential

\[ V(E) = \frac{\gamma^2}{E - E_d} \]

Very strong

Resonant impurities are like vacancies

\[ \gamma^2 \gg |E_d| |t| \]

Parameters from DF calculations

\[ \gamma = 2t \] for all kind of defects under consideration

\[ E_d = - \frac{t}{16} \] for hydrogen and organic groups (C-C bonds)

\[ E_d = - t \] for fluorine and OH

\[ E_d = 0 \] for vacancies
Resonant impurities III

Boltzmann equation

\[ \sigma \approx \left( \frac{2e^2}{h} \right) \frac{2}{\pi} \frac{n_e}{n_i} \ln^2 \left| \frac{E_F}{D} \right| \]

Confirmed by many experiments (e.g., for graphene on SrTiO\textsubscript{3})

Asymmetry

\[ \sigma \propto (q_0 \pm k_F \ln k_F R)^2 \]
Numerical simulations

The method: Yuan, De Raedt & MIK, PR B 82, 115448 (2010)
Applications: Yuan, De Raedt & MIK, PR B 82, 235409 (2010) bi- and trilayer
Yuan, Roldan & MIK, PR B 84, 035439 (2010) plasmons and EELS
Yuan, Roldan & MIK, PR B 84, 125435 (2010) bi- and trilayer, Landau spectrum
Yuan, Roldan, De Raedt & MIK, PR B 84, 195418 (2011) optics
Yuan, Wehling, Lichtenstein & MIK (2012) static screening and localization

Basic idea: calculation of evolution operator via Chebyshev
polynom expansion plus average over some random initial state

\[ |\phi(t)\rangle = \widetilde{U} |\phi(0)\rangle = e^{-itH} |\phi(0)\rangle \]

\[ T_m(x) = \cos[m \arccos(x)], x \in [-1,1] \]
\[ T_{m+1}(x) + T_{m-1}(x) = 2xT_m(x) \]

\[ e^{-izx} = J_0(z) + 2 \sum_{m=1}^{\infty} (-i)^m J_m(z) T_m(x) \]

\[ \hat{T}_m(\hat{H}) = (-i)^m T_m(\hat{H}) = (-i)^m \sum_{n=1}^{N} T_m(\hat{E}_n) |E_n\rangle \langle E_n| \]

\[ \hat{T}_0(\hat{H}) |\phi\rangle = |\phi\rangle \]
\[ \hat{T}_1(\hat{H}) |\phi\rangle = -i\hat{H} |\phi\rangle \]
\[ \hat{T}_{m+1}(\hat{H}) |\phi\rangle = -2i\hat{H}\hat{T}_m(\hat{H}) |\phi\rangle + \hat{T}_{m-1}(\hat{H}) |\phi\rangle \]
**Density of states**

\[ \rho(E) = \frac{1}{N} \sum_{n=1}^{N} \delta(E - E_n) \]

\[ |\varphi(0)\rangle = \sum_n a_n |E_n\rangle = \sum_i b_i c_i^+ |0\rangle_i \]

**Normalized Random Complex Numbers**

\[ \frac{1}{2\pi} \int_{-\infty}^{\infty} e^{iEt} \langle \varphi(0) | \varphi(t) \rangle = \sum_n |a_n|^2 \delta(E - E_n) \approx \rho(E) \]

10^7 sites!!!

Test: ideal SLG, nearest-neighbour approx. (analytic DOS is known)
DOS with resonant impurities

Midgap states and impurity band for hydrogen impurities (left) and vacancies (right)
Optics

Kubo Formula:

\[
\sigma_{\alpha\beta}(\omega) = \lim_{\varepsilon \to 0^+} \frac{1}{(\omega + i\varepsilon)\Omega} \left\{ -i \langle [P_\alpha, J_\beta] \rangle + g_{\alpha\beta}(\omega) \right\}
\]

\[
g_{\alpha\beta}(\omega) = \int_0^\infty dt e^{i(\omega + i\varepsilon)t} \langle [J_\alpha(t), J_\beta] \rangle
\]

\[
P = e \sum_i r_i c_i^+ c_i, \quad J = i[H, P] = -ie \sum_i t_i, j (r_j - r_i) c_i^+ c_i, \quad n_F = \frac{1}{1 + e^{\beta(H - \mu)}}
\]

\[
\text{Re} \sigma_{\alpha\beta}(\omega) = \lim_{\varepsilon \to 0^+} \frac{e^{-\beta\omega}}{\omega\Omega} - \frac{1}{\omega\Omega} \int_0^\infty dt e^{-\varepsilon t} \sin \omega t
\]

\[
\times 2 \text{Im} \langle \varphi | n_F(T, \mu) e^{iHt} J_\alpha e^{-iHt} [1 - n_F(T, \mu)] J_\beta | \varphi \rangle
\]

\(\varphi\) is a random function as at calculations of DOS
Background in IR optics (states in the gap)


Experiment: defects or many-body?
dc Conductivity

Kubo Formula with $\omega = 0$

$$\sigma(\omega = 0) = -\frac{1}{\Omega} \text{Tr} \left\{ \frac{\partial f}{\partial H} \int_0^\infty dt \frac{1}{2} [JJ(t) + J(t)J] \right\}$$

$$T=0 \approx -\frac{1}{\Omega} \frac{\rho(E)}{\langle \phi | \varepsilon \rangle} \int_0^\infty dt \text{Re} \left[ e^{-iEt} \langle \phi | Je^{iHt} J | \varepsilon \rangle \right]$$

Agrees with Boltzmann equation far enough from neutrality point and for small enough defect concentration.
Sensitivity to the nearest-neighbor hopping

Quantum capacitance measurements of electron-hole asymmetry and next-nearest-neighbor hopping in graphene

A. Kretinin, G. L. Yu, R. Jalil, Y. Cao, F. Withers, A. Mishchenko, M. I. Katsnelson, K. S. Novoselov, A. K. Geim, and F. Guinea

\[ t' \approx -0.3 \text{ eV} \pm 15\% \]
Sensitivity to the nearest-neighbor hopping II

Fingerprints of disorder source in graphene
Pei-Liang Zhao, Shengjun Yuan, Mikhail I. Katsnelson, and Hans De Raedt

PHYSICAL REVIEW B 92, 045437 (2015)

Strong e-h asymmetry!

IR optics, Landay levels... RI scattering is quite different from all other sources
**Ripples and puddles I**

Gibertini, Tomadin, Polini, Fasolino & MIK, PR B 81, 125437 (2010)

Atomic coordinates from atomistic MC simulations for thermal ripples

![Graph showing average displacements](image)

**FIG. 2.** (Color online) Average displacements $\overline{u}(r)$ calculated as discussed in Sec. II A. The color scale represents the $\hat{z}$ component of the average displacements, varying from $-3.0$ Å (blue) to $+3.0$ Å (red). The arrows, whose length has been multiplied by a factor ten for better visibility, represent the in-plane components of the average displacements.
**Ripples and puddles II**

Scalar potential

$$V_1 = g_1(u_{xx} + u_{yy})$$

Vector potential

$$V_2 = g_2(u_{xx} - u_{yy} + 2i u_{xy})$$

Distribution of potentials

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**FIG. 3.** (Color online) Left panel: color plot of the scalar potential $V_1(r)$ (in units of meV) calculated using Eq. (2) with $g_1 = 3$ eV. Central panel: the real part of the potential $V_2(r)$ (in units of meV) calculated using Eq. (3). Right panel: the imaginary part of the potential $V_2(r)$ (in units of meV).
**FIG. 4.** (Color online) Top panel: fully self-consistent electronic density profile $\delta n(r)$ (in units of $10^{12} \text{ cm}^{-2}$) in a corrugated graphene sheet. The data reported in this figure have been obtained by setting $g_1=3$ eV, $\alpha_{ee}=0.9$ (this value of $\alpha_{ee}$ is the commonly used value for a graphene sheet on a SiO$_2$ substrate), and an average carrier density $\overline{n}_c \approx 0.8 \times 10^{12} \text{ cm}^{-2}$. Bottom panel: same as in the top panel but for $\alpha_{ee}=2.2$ (this value of $\alpha_{ee}$ corresponds to suspended graphene).

**FIG. 9.** (Color online) One-dimensional plots of the self-consistent density profiles (as functions of $x$ in nm for $y=21.1$ nm) for different values of doping: $\overline{n}_c \approx 0.8 \times 10^{12} \text{ cm}^{-2}$ (circles), $\overline{n}_c \approx 3.96 \times 10^{12} \text{ cm}^{-2}$ (triangles), and $\overline{n}_c \approx 3.17 \times 10^{13} \text{ cm}^{-2}$ (squares). The data reported in this figure have been obtained by setting $g_1=3$ eV and $\alpha_{ee}=2.2$. The inset shows $\delta n(r)$ (in units of $10^{12} \text{ cm}^{-2}$) at a given point $r$ in space as a function of the average carrier density $\overline{n}_c$ (in units of $10^{12} \text{ cm}^{-2}$).
Ripples and puddles IV

Graphene on SiO$_2$

Gibertini, Tomadin, Guinea, MIK & Polini PR B 85, 201405 (2012)

Experimental STM data: V.Geringer et al (M.Morgenstern group)

FIG. 3: (Color online) Fully self-consistent induced carrier-density profile $\delta n(r)$ (in units of $10^{12}$ cm$^{-2}$) in the corrugated graphene sheet shown in Fig. 1. The data reported in this figure have been obtained by setting $g_1 = 3$ eV, $\alpha_{ee} = 0.9$, and an average carrier density $\bar{n}_c \approx 2.5 \times 10^{11}$ cm$^{-2}$. The thin solid lines are contour plots of the curvature $\nabla^2 h(r)$. Note that there is no simple correspondence between topographic out-of-plane corrugations and carrier-density inhomogeneity.
Scattering by ripples

Mk & Geim, Phil. Trans. R. Soc. A 366, 195 (2008)

Scattering by random vector and scalar potential:

\[ H' = \sum_{pp'} \Psi_p^\dagger V_{pp'} \Psi_{p'} \]

\[ V_{pp'} = V_{pp'}^{(0)} + A_{pp'}^{(x)} \sigma_x + A_{pp'}^{(y)} \sigma_y \]

\[ \frac{1}{\tau} = \frac{4\pi}{\hbar N (\varepsilon_F)} \sum_{pp'} \delta (\varepsilon_p - \varepsilon_F) \delta (\varepsilon_{p'} - \varepsilon_F) (\cos \theta_p - \cos \theta_{p'})^2 |W_{pp'}|^2 \]

\[ W_{pp'} = V_{pp'}^{(0)} \left( 1 + \exp \left[ -i (\theta_p - \theta_{p'}) \right] \right) + \frac{1}{2} \left[ \left( A_{pp'}^{(x)} + i A_{pp'}^{(y)} \right) \exp (-i \theta_p) + \left( A_{pp'}^{(x)} - i A_{pp'}^{(y)} \right) \exp (i \theta_{p'}) \right] \]
Scattering by ripples II

Estimations:

\[
\frac{1}{\tau} \approx \frac{2\pi N (\varepsilon_F)}{\hbar} \left( \langle V_q^{(0)} V_{-q}^{(0)} \rangle + \langle A_q A_{-q} \rangle \right) q \approx k_F
\]

\[
\langle V_q V_{-q} \rangle \approx \left( \frac{\hbar v_F}{a} \right)^2 \sum_{q_1 q_2} \langle h_{q-q_1} h_{q_1} h_{-q+q_2} h_{-q_2} \rangle [(q - q_1) \cdot q_1][(q - q_2) \cdot q_2]
\]

Self-consistent screening approximation (Zakharchenko, Roldan, Fasolino & MIK)

“Harmonic” ripples @ RT

\[
k_F \geq q^*
\]
Quantum theory: two-phonon processes
At high $T$ roughly the same result
Strong sensitivity to the strains
via frequency of flexural phonons:

$$\omega^F_{\vec{q}}(\vec{r}) = |\vec{q}| \sqrt{\frac{\kappa}{\rho} |\vec{q}|^2 + \frac{\lambda}{\rho} u_{ii}(\vec{r}) + \frac{2\mu}{\rho} u_{ij}(\vec{r}) \frac{q_i q_j}{|\vec{q}|^2}}$$

Quantitative results and comparison with experiment on freely suspended samples:
Castro, Ochoa, MIK, Gorbachev, Elias, Novoselov, Geim & Guinea, PRL 105, 266601 (2010)
Flexural phonons

H.Ochoa, E.Castro, MIK, F.Guinea 2010

1. Mobility at RT cannot be higher than on substrate for the flexural phonons only
2. It can be essentially increased by applying a strain

Qualitative agreement between classical and quantum theory @ RT

Exper. data

T-dependence of mobility for two samples
Three candidates to the main scattering mechanism (long range is necessary!!!)

Coulomb centers? (I personally doubt: no effect of high-kappa environment, tendencies to clusterize for ionic impurities)

Ripples? (aka flexural phonons, probably the main mechanism for suspended graphene). For graphene on substrate: need quenching mechanism

Resonant impurities? Carbon-carbon bonds between garbage and graphene (Strong electron-hole symmetry is a fingerprint)
Main collaborators

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Sasha Lichtenstein, Tim Wehling (Hamburg)

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